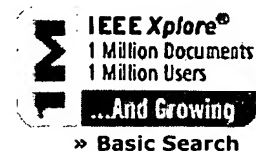




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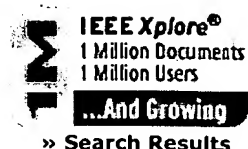
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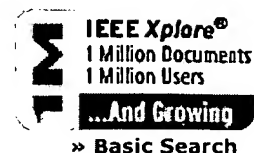
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Radar Conference, 2004. Proceedings of the IEEE , 26-29 April 2004

Pages:271 - 276

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<u>L23</u>	119 and deconvolut\$3	0	<u>L23</u>
<u>L22</u>	rmmse	0	<u>L22</u>
<u>L21</u>	reiterative adj minimum adj mean adj square adj error	0	<u>L21</u>
<u>L20</u>	predictive adj deconvolution	0	<u>L20</u>
<u>L19</u>	radar\$1	72	<u>L19</u>

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<u>L18</u>	117 and estimat\$4	20	<u>L18</u>
<u>L17</u>	116 and error\$1	221	<u>L17</u>
<u>L16</u>	111 and compress\$4	1062	<u>L16</u>
<u>L15</u>	111 and deconvolut\$3	0	<u>L15</u>
<u>L14</u>	rmmse	0	<u>L14</u>
<u>L13</u>	reiterative adj minimum adj mean adj square adj error	0	<u>L13</u>
<u>L12</u>	predictive adj deconvolution	0	<u>L12</u>
<u>L11</u>	radar\$1	10694	<u>L11</u>

DB=PGPB,USPT,EPAB,JPAB,DWPI; PLUR=YES; OP=OR

<u>L10</u>	19 and mean	89	<u>L10</u>
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<u>L9</u>	l8 and estimat\$4	216	<u>L9</u>
<u>L8</u>	l7 and error\$1	480	<u>L8</u>
<u>L7</u>	l1 and compress\$4	2212	<u>L7</u>
<u>L6</u>	l1 and deconvolut\$3	48	<u>L6</u>
<u>L5</u>	rmmse	0	<u>L5</u>
<u>L4</u>	reiterative adj minimum adj mean adj square adj error	0	<u>L4</u>
<u>L3</u>	l1 and l2	0	<u>L3</u>
<u>L2</u>	predictive adj deconvolution	43	<u>L2</u>
<u>L1</u>	radar\$1.ti,ab.	43203	<u>L1</u>

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